## Lecture 24

## Today we will

- Review charging of output capacitance (origin of gate delay)
- Calculate output capacitance
- Discuss fan-out
- Discuss "complementary" nature of CMOS

ORIGIN OF GATE DELAY


When the inputs $A$ and $B$ change such that the output $F$ changes,
the output cannot change instantaneously; the output capacitance must be charged or discharged.

This is GATE DELAY.

## REVIEW: PULL-DOWN DEVICES

In our logic circuits, the NMOS transistors have

- Gate terminal connected to $\mathrm{V}_{\mathbb{I N}}$
- Source terminal connected to ground directly, or through another NMOS
This means
- When $\mathrm{V}_{\mathrm{IN}}$ is high, NMOS transistors are "on". They help pull-down $\mathrm{V}_{\text {OUT }}$ to ground, by conducting current to discharge the output capacitance.
- When $\mathbf{V}_{\mathbf{I N}}$ is low, NMOS transistors are "off". They act as open circuits from source to drain.


## REVIEW: PULL-UP DEVICES

In our logic circuits, the PMOS transistors have

- Gate terminal connected to $\mathrm{V}_{\mathbb{I}}$
- Source terminal connected to $\mathrm{V}_{\mathrm{DD}}$ directly, or through another PMOS
This means
- When $\mathrm{V}_{\mathrm{IN}}$ is low, PMOS transistors are "on". They help pull-up $\mathrm{V}_{\text {OUT }}$ to $\mathrm{V}_{\mathrm{DD}}$, by conducting current to charge the output capacitance.
- When $\mathrm{V}_{\mathrm{IN}}$ is high, PMOS transistors are "off". They act as open circuits from source to drain.


## REVIEW: MODEL FOR GATE DELAY ANALYSIS

There is a model for the behavior of transistors in a CMOS logic circuit to analyze charging/discharging of the output capacitance.
$\begin{array}{ll}V_{I N}=0 & \text { (for NMOS) } \\ V_{I N}=V_{D D}(\text { for PMOS) }\end{array}$
$\mathrm{V}_{\mathrm{IN}}=\mathrm{V}_{\mathrm{DD}}$ (for NMOS)
$\mathrm{V}_{\mathrm{IN}}=0 \quad$ (for PMOS)


The resistance $R$ is the effective resistance for the device during the first half of the transition.

Each device can have different R!
G.


## REVIEW: CALCULATING EFFECTIVE RESISTANCE

Consider pull-down, when $\mathrm{V}_{\text {OUT }}$ must go from $\mathrm{V}_{\mathrm{DD}}$ to 0 V .


We calculate $R_{N}$ by averaging the values of $V_{D S(N)} / I_{D(N)}$ at the beginning and ending of delay.

$$
R_{N}=3 / 4 V_{D D} / I_{D S A T(N)}
$$

$$
R_{P}=-3 / 4 V_{D D} / I_{D S A T(P)}
$$

## CALCULATING OUTPUT CAPACITANCE

Two major sources of capacitance:

1. The transistor gates in the next stage
2. The metal connection to the next stage

Both can be computed using the parallel plate capacitor formula:
$C=A \frac{k \varepsilon_{0}}{d}$
A is the area of the plates,
$k$ is the dielectric constant of the insulator in between the plates,
$e_{0}$ is the permittivity of free space, and
$d$ is the distance in between the plates.
We denote $C_{O X}=\frac{k \varepsilon_{0}}{d}$ since this is fixed by fabrication process.

## CALCULATING OUTPUT CAPACITANCE

Each transistor gate terminal attached to the output contributes a gate capacitance
where W and L are the channel

$$
C_{G}=W L C_{O X}
$$ dimensions and $\mathrm{C}_{0 x}$ is the capacitance of the gate per unit area (parameters from $I_{D} v s . V_{D S}$ ).

Each metal connection at the output contributes a capacitance also given by the parallel plate capacitor formula, but with different length, width, and capacitance per unit area.

$$
C_{I}=W_{I} L_{I} \frac{k \varepsilon_{0}}{d}=W_{I} L_{I} C_{O X(I)}
$$




Use
$V_{D D}=5 \mathrm{~V}$
$\mathrm{V}_{\mathrm{TH}(\mathrm{N})}=-\mathrm{V}_{\mathrm{TH}(\mathrm{P})}=1 \mathrm{~V}$
$\mathrm{C}_{\mathrm{OX}}=5 \mathrm{fF} / \mu \mathrm{m}^{2}$ for both transistors
$\mathrm{L}=2 \mu \mathrm{~m}$ for both transistors
$\mathrm{W}=2 \mu \mathrm{~m}$ for both transistors
$\lambda=0$ for both transistors
$\mu_{\mathrm{N}}=50000 \mathrm{~mm}^{2} /(\mathrm{V}$ s)
$\mu_{\mathrm{p}}=25000 \mathrm{~mm}^{2} /(\mathrm{V} \mathrm{s})$
$\mathrm{W}_{\mathrm{I}}=2 \mu \mathrm{~m}$
$\mathrm{L}_{1}=200 \mu \mathrm{~m}$
$\mathrm{C}_{\mathrm{OX}(1)}=0.1 \mathrm{fF} / \mu \mathrm{m}^{2}$

Calculate the effective resistance and total output capacitance due to gate and interconnect capacitance.

## EXAMPLE

Since $\mathrm{V}_{\text {IN }}$ is now low, $\mathrm{V}_{\text {OUT1 }}$ must go from low to high. Pull-up


Now calculate $\mathrm{C}_{\mathrm{OUT}}$ :
There are 4 transistor gates attached to inverter output, and one wire connecting the inverter output to the NAND input.
$\mathrm{C}_{\text {OUT }}=$
$\mathrm{C}_{\mathrm{G}}=$
$\mathrm{C}_{1}=$
$\mathrm{C}_{\text {OUT }}=$
$t_{p}=$

## FAN-OUT

Consider our previous example.
Suppose that we connected N NAND gates to the output of the inverter.

Each NAND gate adds 4 more gate capacitances and another interconnect capacitance.
$\mathrm{C}_{\text {OUT }}=$
$t_{p}=$
The fan-out, or number of logic gates that can be attached to an output, is limited by propagation delay considerations.

## LOOKING AT CMOS CIRCUITS



One can often "see" the logical operation in a CMOS circuit by looking at either the top or bottom half of the circuit.

For example, looking at the top half of this circuit, we see that the output will be connected to $\mathrm{V}_{\mathrm{DD}}$ ( F is high) when:
(B OR C is low) AND A is low
$F=(\bar{B}+\bar{C}) \bar{A}$

## LOOKING AT CMOS CIRCUITS



The bottom half of the circuit always results in the same equation as the top half, just rewritten via DeMorgan (that's why output is always defined).

Looking at the bottom half of this circuit, we see that the output will be connected to ground ( F is low) when:
( B AND C are high) OR A is high
$F=B C+A$
$F=B C+A$

